Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/815,881	ALGER ET AL.
Examiner	Art Unit
Tae H. Yoon	1714

	SEARCHED					
Class	Subclass	Date	Examiner			
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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